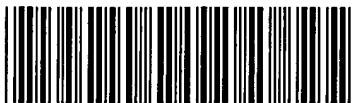


**Search Notes**

Application/Control No.

10/509,337

Examiner

Richard Chan

Applicant(s)/Patent under  
Reexamination

AIKAWA ET AL.

Art Unit

2618

**SEARCHED**

Class	Subclass	Date	Examiner
455	101	12/19/2006	RC
455	103	12/19/2006	RC
455	105	12/19/2006	RC
455	127.1	12/19/2006	RC
375	144	12/19/2006	RC
375	146	12/19/2006	RC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Please See East Search report	12/19/2006	RC